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1. Highlights in 2007

(1) Development of lead free piezoelectric material

Novel type of phase boundary in lead-free materials is discovered. This can be expanding to the large number of compounds. Electrical properties of these are under investigation.

(2) Growth of PZT single crystal films

Unipolar-axis-oriented tetragonal PZT thick films up to 3 μm were successfully grown using novel substrates, even though the previous film thickness was limited below 100 nm. This novel substrate can be applicable to the other materials growth.

(3) Film growth of paraelectric tunable dielectrics

Epitaxial film growth of paraelectric materials with low loss was successfully grown on the bottom electrode having same crystal structure and their electrical property was investigated.

2. Articles

(2-1) Original articles

1. "Fabrication of ZnO Microstructures by Anisotropic Wet-Chemical Etching",
Naoki Ohashi, Kenji Takahashi, Shunichi Hishita, Isao Sakaguchi, Hiroshi Funakubo and
Hajime Haneda,
J. Electrochem. Soc., 154(2) (2007). D82-D87.
2. "Single-phase $\text{Pb}(\text{Zn}_{1/3}\text{Nb}_{2/3})\text{O}_3$ thin films grown by metalorganic chemical vapor deposition:
Effects of growth sequence and substrates", Ken Nishida, Shintaro Yokoyama, Satoshi
Okamoto, Keisuke Saito, Hiroshi Uchida, Seiichiro Koda, Takashi Katoda and Hiroshi
Funakubo,
J. Crystal Growth, 298 (2007) 495-499.
3. "(111)-Oriented SrRuO_3/Pt Bottom Electrode for Reproducible Preparation of Metal Organic
Chemical Vapor Deposited $\text{Pb}(\text{Zr}, \text{Ti})\text{O}_3$ Films for High Density Ferroelectric Random Access
Memories",
Nicolas Menou, Hiroki Kuwabara and Hiroshi Funakubo,
IEICE Technical Report, 106 (593), 2007, SDM2006-258 (2007-03), 21-26.
4. "Probing intrinsic polarization properties in bismuth-layered ferroelectric films",
Takayuki Watanabe, Hiroshi Funakubo, Minoru Osada, Hiroshi Uchida, Isao Okada, Brian J.

- Rodriguez and Alexei Gruverman,
Appl. Phys. Lett., 90, (2007)112914-1-3.
5. "Domain structures in highly (100)-oriented epitaxial $\text{Pb}(\text{Zr}_{0.35}\text{Ti}_{0.65})\text{O}_3$ thin films",
Yong Kwan Kim, Hitoshi Morioka, and Hiroshi Funakubo,
J. Appl. Phys., 101 (2007) 064112.
 6. "Crystal Growth of $\beta\text{-FeSi}_2$ Thin Film on (100), (110) and (111) Plane of Si and Yttria-Stabilized Zirconia Substrates",
Kensuke Akiyama, Satoru Kaneko, Takanori Kiguchi, Takashi Suemasu, Takeshi Kimura and Hiroshi Funakubo,
Mater. Res. Soc. Symp. Proc., 980 (2007) 0980-II05-47.
 7. "Effect of the thermal expansion matching on the dielectric tenability of (100)-one-axis-oriented $(\text{Ba}_{0.5}\text{Sr}_{0.5})\text{TiO}_3$ thin films",
Shinichi Ito, Hiroshi Funakubo, Ivoyl P. Koutsaroff, Marina Zelner and Andrew Cervin-Lawry,
Appl. Phys. Lett., 90, (2007)142910-1-3.
 8. "Low-Temperature Preparation of Metallic Ruthenium Films by MOCVD Using Bis(2,4-dimethylpentadienyl)ruthenium",
Kazuhisa Kawano, Hiroaki Kosuge, Noriaki Oshima and Hiroshi Funakubo,
Electrochem. Solid-State Lett., 10(6) (2007) D60-D62.
 9. "Characterization of zinc-modified lithium tantalate thin films fabricated by chemical solution deposition method",
Hiroshi Uchida, Katsumi Onofuji, Hiroshi Funakubo and Seiichiro Koda,
J Sol-Gel Sci Techn, 42 (2007) 265–269.
 10. "Impact of (111)-Oriented SrRuO_3/Pt Tailored Electrode for Highly Reproducible Preparation of Metal Organic Chemical Vapour Deposited $\text{Pb}(\text{Zr},\text{Ti})\text{O}_3$ Films for High Density Ferroelectric Random Access Memory Applications",
Nicolas Menou, Hiroki Kuwabara and Hiroshi Funakubo,
Jpn. J. Appl. Phys., 46(4B) (2007) pp.2139-2142.
 11. "La Content Dependence of Piezoelectric Properties of Polycrystalline $(\text{Pb}, \text{La}(\text{Zr}_{0.65}, \text{Ti}_{0.35}))\text{O}_3$ Films",
H.Shima, H. Naganuma, T. Iijima, H. Funakubo and S.Okamura,
Trans. Mater. Res. Jpn, 32[1] (2007) pp.79-82.
 12. "Crystal structure and microstructure of epitaxial $\text{Pb}(\text{Zr},\text{Ti})\text{O}_3$ films consisting of mixed phases with tetragonal and rhombohedral symmetries grown on $(100)_c\text{SrRuO}_3// (100)\text{SrTiO}_3$ substrate by metalorganic chemical vapor deposition",
Shintaro Yokoyama, Hitoshi Morioka, Yong Kwan Kim, Hiroshi Nakaki, Hiroshi Funakubo,

- Keisuke Saito, Ken Nishida and Takashi Katoda,
J. Mater. Res., 22(6) (2007), pp.1551-1557.
13. “Strain and in-plane orientation effects on the ferroelectricity of (111)-oriented tetragonal $\text{Pb}(\text{Zr}_{0.35}\text{Ti}_{0.65})\text{O}_3$ thin films prepared by metal organic chemical vapor deposition”,
Hiroki Kuwabara, Nicolas Menou and Hiroshi Funakubo,
Appl. Phys. Lett., 90, (2007) 222901-1-3.
 14. “(111)-textured Mn-substituted BiFeO_3 thin films on $\text{SrRuO}_3/\text{Pt}/\text{Ti}/\text{SiO}_2/\text{Si}$ structures”,
S. K. Singh, N. Menou, H. Funakubo, K. Maruyama and H. Ishiwara,
Appl. Phys. Lett., 90 (2007) 242914-1-3.
 15. “Enhancement of field-induced strain by La substitution in epitaxial $\text{Pb}(\text{Zr},\text{Ti})\text{O}_3$ films grown by metal organic chemical vapor deposition”,
Ken Nishida, Yoshihisa Honda, Shintaro Yokoyama, Hiroshi Funakubo, Takashi Yamamoto, Keisuke Saito and Takashi Katoda,
Appl. Phys. Lett., 90, (2007) 262902-1-3.
 16. “Oxygen Content and Magnetic Properties of SrRuO_3 Thin Films”,
Joe Sakai, Nobuaki Ito, Shin-Ichi Ito, Kenji Takahashi and Hiroshi Funakubo,
IEEE Transactions on Magnetism, 43(6), (2007) pp.3073-3075.
 17. “Analysis for crystal structure of $\text{Bi}(\text{Fe},\text{Sc})\text{O}_3$ thin films and their electrical properties”,
Shintaro Yasui, Hiroshi Uchida, Hiroshi Nakaki, Ken Nishida, Hiroshi Funakubo and Seiichiro Koda,
Appl. Phys. Lett., 91, (2007) 022906-1-3.
 18. “Bottom Electrodes Dependence of Ferroelectric Properties in Epitaxial $\text{BiFeO}_3/\text{SrRuO}_3/\text{SrTiO}_3$ Structures”,
S.K.Sungh, Y.K.Kim, H.Kuwabara, H.Funakubo and H.Ishiwara,
Integ. Ferroelectrics, 87 (2007) 42–49.
 19. “Effect of source materials on film thickness and compositional uniformity of MOCVD- $\text{P}(\text{Zr},\text{Ti})\text{O}_3$ films”,
Hiroshi Funakubo, Atsushi Nagai, Gouji Asano, June-Mo Koo, Sang-Min Shin and Youngsoo Park,
Surface & Coatings Tech., 201 (2007) 9279–9284.
 20. “Effect of Oxygen Annealing on Ferroelectricity of BiFeO_3 Thin Films Formed by Pulsed Laser Deposition”,
Hyun-young Go, Naoki Wakiya, Hiroshi Funakubo, Keisuke Satoh, Masao Kondo, Jeffrey S. Cross, Kenji Maruyama, Nobuyasu Mizutani, and Kazuo Shinozaki,
Jpn. J. Appl. Phys., 46(6A)(2007) pp.3491-3494.
 21. “ $\beta\text{-FeSi}_2$ growth on Cu-mediated Si substrate and enhancement of photoluminescence”,

- Kensuke Akiyama, Masaru Itakura, Satoru Kaneko, Hiroshi Funakubo and Yoshihito Maeda,
Thin Solid Films, 515(2007) 8144-8148.
22. "1.54 μm photoluminescence from $\beta\text{-FeSi}_2$ as-deposited film",
Kensuke Akiyama, Satoru Kaneko, Hiroshi Funakubo and Masaru Itakura,
Appl. Phys. Lett., 91, (2007) 071903-1-3.
 23. "Satellite peaks amplified by modulation in bismuth cuprate thin film",
S. Kaneko, K. Akiyama, T. Ito, Y. Hirabayashi, K. Seo, H. Funakubo and M. Yoshimoto,
Physica C, 463-465 (2007) 935-938.
 24. "Strain-relaxed structure in (001)/(100)-oriented epitaxial PbTiO_3 films grown on (100)
 SrTiO_3 substrates by metal organic chemical vapor deposition",
Hiroshi Nakaki, Yong Kwan Kim, Shintaro Yokoyama, Rikyu Ikariyama, Hiroshi Funakubo,
Ken Nishida and Keisuke Saito,
Appl. Phys. Lett., 91 (2007) 112904-1-3.
 25. "Crystal Structure Analysis of Epitaxial $\text{BiFeO}_3\text{-BiCoO}_3$ Solid Solution Films Grown by
Metalorganic Chemical Vapor Deposition",
Shintaro Yasui, Ken Nishida, Hiroshi Naganuma, Soichiro Okamura, Takashi Iijima and
Hiroshi Funakubo,
Jpn. J. Appl. Phys., 46(10B)(2007).6948-6951.
 26. "Solution-Based Fabrication of High- κ Dielectric Nanofilms Using Titania Nanosheets as a
Building Block",
Minoru Osada, Kosho Akatsuka, Yasuo Ebina, Hiroshi Funakubo, Takanori Kiguchi,
Kazunori Takada and Takayoshi Sasaki,
Jpn. J. Appl. Phys., 46(10B) (2007) 6979-6983.
 27. "RF Magnetron Sputtering Growth of Epitaxial SrRuO_3 Films with High Conductivity",
Takafumi Kamo, Ken Nishida, Kensuke Akiyama, Joe Sakai, Takashi Katoda and Hiroshi
Funakubo,
Jpn. J. Appl. Phys., 46(10B) (2007) 6987-6990.
 28. "Evaluation of Residual Strain and Oxygen Vacancy in Multilayer Ceramic Capacitor
Using Laser Raman Spectroscopy",
Ken Nishida, Hiroshi Kishi, Hiroshi Funakubo, Hironari Takeuchi, Takashi Katoda and
Takashi Yamamoto,
Jpn. J. Appl. Phys., 46(10B) (2007) 7005-7007.
 29. "Structural characterization by electronic transport properties on Fe_3Si films,
Y Kobayashi, T Kaneko, M Kamogawa, K Asai, K Akiyama and H Funakubo,
J. Phys. D: Appl. Phys. 40 (2007) 6873-6878.
 30. "(111)-oriented $\text{Pb}(\text{Zr,Ti})\text{O}_3$ films deposited on SrRuO_3/Pt electrodes: Reproducible

preparation by metal organic chemical vapor deposition, top electrode influence, and reliability”,

Nicolas Menou and Hiroshi Funakubo,

J. Appl. Phys., 102 (2007) 114105-1-5.

31. “Morphology of sol–gel produced composite films for optical oxygen sensors”,
S. Anastasova, M. Milanova, E. Kashchieva, H. Funakubo, T. Kamo, N. Grozev, P. Stefanov
and D. Todorovsky,
Appl. Surface Sci., 254 (2008) 1545–1558.
32. “In situ gas-phase FTIR monitoring of liquid delivery MOCVD process for PZT film
preparation”,
Hiroshi Funakubo, Gouji Asano, Kazuaki Tonari, Yukichi Takamatsu, Kunio Ohtsuki and
Tsukasa Satake,
Chem. Eng. J., 135 (2008) 10–14.
33. “Cubic-on-cubic growth of a MgO(001) thin film prepared on Si(001) substrate at low
ambient pressure by the sputtering method”,
S. Kaneko, H. Funakubo, T. Kadowaki, Y. Hirabayashi and K. Akiyama,
Euro Pys. Lett., 81 (2008) 46001-1-5.
34. “Effect of Strain on Supercell Structure of Bismuth Cuprate Superconducting Film”,
Satoru Kaneko, Kensuke Akiyama, Masahiko Mitsuhashi, Takeshi Ito, Masao Kumagai,
Hiroshi Funakubo and Mamoru Yoshimoto,
Jpn. J. Appl. Phys., 47(1), (2008) 664-666.
35. “Epitaxial Growth of Ferromagnetic Iron Silicide Thin Films on Silicon with Ytria-Stabilized
Zirconia Buffer Layer”,
Kensuke Akiyama, Satoru Kaneko, Teiko Kadowaki, Yasuo Hirabayashi and Hiroshi
Funakubo,
Jpn. J. Appl. Phys., 47(1), (2008) pp.577-579.
36. “Preparation of (111)-Oriented SrRuO₃/Pt Electrodes for Pb(Zr,Ti)O₃-Based Ferroelectric
Capacitors: Grain Size and Roughness Impact”, Nicolas Menou and Hiroshi Funakubo,
Jpn. J. Appl. Phys., 47(2), (2008)1003-1007.

(2-2) Comment

- 1 “Novel dielectric property of bithmuthlayered dielectrics along the stacj direction”, (in
Japanese)
Cremaics, 42(3)2007, pp.169-174.
- 2 “Importance of in situ Monitoring in MOCVD Process and Future Prospects”,
Hiroshi Funakubo,

Readout Horiba Technical Reports, 11, Feb. 2007, pp.54-59.

- 3 “Thickness-degradation-free Dielectric Thin Films”,
Hiroshi Funakubo and Osami Sakata, SPring-8/JASRI, July 2007,
“Spring-8 Research Frontiers 2006”, (2007) pp.87-88.
- 4 “Development of interface of Oxide — From the Practical Application point of view—”, (in
Japanese)
Hiroshi Funakubo, Osami Sakata, Nobuyasu Mizutani, *Seramics data book 2007*, 35(89)
pp.47-52.
- ① “Nanostructural Characterization of Surfaces, Interfaces, and thin films using X-ray
Reciprocal-Lattice Space Imaging”,
Osami Sakata, Mamoru Yoshimoto, Kazushi Miki, Masashi Nakamura,
Journal of the Crystallographic Society of Japan, 49 (2007) pp.292-299.

(2-3) • Book

1. “MOCVD method”,
Hiroshi Funakubo, and Shintaro Yausi,
Improvement of Piezoelectric materials and their applications
Chapter 2.6, (2007) pp.168-178.

3. Invited presentation in International/domestic conference

(3-1) International conference

- 1) Hiroshi Funakubo, Kenji Takahashi, Muneyasu Suzuki, Takashi Kojima, Takayuki Watanabe,
Kazumi Kato, Yukio Sakashita, Kazushi Sumitani and Osami Sakata,
“Degradation Free Characteristics Of c-Axis Oriented Bismuth Layer-Structured Dielectrics”,
International Symposium on Integrated Ferroelectrics (ISIF 2007), Bordeaux, France, May 8-11,
2007, 4A-70-I, p.30.
- 2) H. Funakubo,
“Film thickness dependence of the dielectric thin films in c-axis oriented bismuth layer
perovskite materials”,
The Fifth China International Conference on High-Performance Ceramics (CICC-5), Vava
Huatian International Hotel, Changsha, China, May 10-13, 2007, SB007, p.43.
- 3) H. Funakubo, S. Okaura, H. Uchida, S. Koda, M. Osada, and K. Nishida,
“Composition and Substrate Dependences of Dielectric Tunability in Bi-Zn-Nb-O Pyrochlore
Films Prepared by MOCVD”,

The American Ceramic Society's 109th Annual Meeting, Materials Science & Technology 2007 Conference and Exhibition (MS&T'07), COBO Center, Detroit, Michigan, U.S.A., Sep. 16-20, 2007, p.131.

- 4) Hiroshi Funakubo; Shintaro Yokoyama; Satoshi Okamoto; Keisuke Saito; Takashi Iijima; Ken Nishida; Takashi Katoda; Joe Sakai; Takashi Yamamoto; and Hirotake Okino;
“Materials Design for Piezoelectric Thick Films from Study on MOCVD Grown Epitaxial Films”, TMS 2008 Annual Meeting & Exhibition, New Orleans, Louisiana, U.S.A., Mar. 9-13, 2008, p.223,

(3-2) Domestic conference

Total 3

4. Others

(4-1) Patent

Total 12

(4-2) Award

Total 3

(4-3) Remarks

Topic presentation in Annual Meeting of Japan Ceramic Society

1 C31L “Growth of Perfectly Polar-axis Oriented Tetragonal PZT Thick Films”

Hiroshi Funakubo, Takashi Fujisawa, Hiroshi Nakaki, Rikyu Ikariyama, Keisuke Saito, and Hitoshi Morioka